Description
The automobile electrical system is poorly regulated and subject to frequent dips and overshoots. Voltage can range from 11 to 15 volts under normal conditions and from 8 to 24 volts under transient starting and running conditions. As a result, voltage margin testing is a necessary part of testing Engine Control Units (ECUs) to verify proper operation and tolerance for extreme bias voltage conditions.

Problem
Every second of test time counts in the competitive automotive electronics marketplace. Testing at multiple bias voltage levels is a necessary, but time consuming part of ECU testing. Most system DC sources available require significant time to change and settle to a new output setting, adding several seconds to the overall test time.

Solution
Agilent Technologies N6700 Modular Power System and N6752A power supply module incorporate features that reduce ECU test time and enhance testing, including:

- The N6752A 50 V, 10 A, 100 W autoranging power supply module features active down programming for fast output downward transitions regardless of load.

- Less than 1 millisecond command processing time reduces test time.
- Less than 4 milliseconds output response time reduces test time.
- Identical modules can be paralleled and operated as a virtual single output for greater output current and power, for testing higher power ECUs.
- Up to four modules fit in the 1-U high mainframe, saving test system space.

ECU Input and Output Characteristics
An ECU takes a myriad of signals monitoring the vehicle and its environment. In turn it manages and controls the engine and ancillary equipment for optimum operation. Figure 1 summarizes the many input and output signals of a typical ECU.
In ECU functional test, appropriate test system resources emulate the various input signals in a controlled manner and load and check the outputs for correct response. It is readily apparent based on the number of inputs and outputs that test system resources for ECU test is quite extensive.

Key Bias Voltage Levels in Automotive Electrical Systems
Depending on the operating state of the vehicle, certain voltage levels are commonly encountered in an automotive electrical system. These levels become key voltages for ECU test, as illustrated in Figure 2. Some relevant tests at key voltages include:

- Continuity between multiple ground, power and high current driver pins is checked with the power supply set to zero or disabled.
- Shorts or other unexpected faults can be checked by applying a very low voltage and measuring the resultant current.
- Various functional tests are run from a low level of around 8 volts, representing starting, up to high level of around 15 volts, representing full charging conditions.
- The ECU voltage monitor circuit, if included, is calibrated or verified, typically by applying two end-point operating voltages at minimum.
- The ECU low voltage reset level is verified by checking its minimum “must not trip” and maximum “must trip” thresholds.

In all, an ECU may be subjected to up to 20 bias voltage level changes during test.
Power Supply Output Response Time

A few steps occur when changing a power supply output voltage setting to a new value, as depicted in Figure 3. These steps all take a finite amount of time.

Once a command is received by the power supply—it must process it; this is its command processing time. The power supply’s output then responds and changes to the new setting. The time it takes to reach its final value, within a certain settling band, is its output response time. A 1% settling band is suitable for ECU test.

Table 1 compares the command processing and output response times of many typical programmable power supplies to the N6700 and N6752A. The exceptional speed characteristics are a result of being designed for high throughput test applications.

It is especially important to take note of down programming output response time. Many power supplies depend upon the actual loading of the DUT to bring the voltage down. Under light loading conditions it can take a second or more for some power supplies without down programmers to reach their final value. The N6752A power supply module incorporates an internal down programmer for fast down programming, independent of the load. Both fast up and down programming speed is important in ECU testing.

Throughput Improvement Using Agilent Technologies N6700 Modular Power System and N6752A Power Supply Module

The test time reduction achieved by switching to the N6700 and N6752A from a slower power supply is a product of the command processing and output response time improvement and the number of output voltage transitions. A 200-millisecond time improvement and 15 output transitions yields a 3 second test time reduction. For an ECU having a 20 second test time, this translates to a 15% improvement in throughput. Such an improvement is highly valued by ECU manufacturers, greatly reducing their cost of test and providing immediate benefit.

Related Applications

• Automotive Electronic Control Modules (ECMs)
• Automotive Body Electronics
• Automotive Telematics
Agilent Technologies’ Test and Measurement Support, Services, and Assistance
Agilent Technologies aims to maximize the value you receive, while minimizing your risk and problems. We strive to ensure that you get the test and measurement capabilities you paid for and obtain the support you need. Our extensive support resources and services can help you choose the right Agilent products for your applications and apply them successfully. Every instrument and system we sell has a global warranty. Support is available for at least five years beyond the production life of the product. Two concepts underlie Agilent’s overall support policy: “Our Promise” and “Your Advantage.”

Our Promise
Our Promise means your Agilent test and measurement equipment will meet its advertised performance and functionality. When you are choosing new equipment, we will help you with product information, including realistic performance specifications and practical recommendations from experienced test engineers. When you receive your new Agilent equipment, we can help verify that it works properly and help with initial product operation.

Your Advantage
Your Advantage means that Agilent offers a wide range of additional expert test and measurement services, which you can purchase according to your unique technical and business needs. Solve problems efficiently and gain a competitive edge by contracting with us for calibration, extra-cost upgrades, out-of-warranty repairs, and onsite education and training, as well as design, system integration, project management, and other professional engineering services. Experienced Agilent engineers and technicians worldwide can help you maximize your productivity, optimize the return on investment of your Agilent instruments and systems, and obtain dependable measurement accuracy for the life of those products.

Agilent Email Updates
www.agilent.com/find/emailupdates
Get the latest information on the products and applications you select.

Agilent T&M Software and Connectivity
Agilent’s Test and Measurement software and connectivity products, solutions and developer network allows you to take time out of connecting your instruments to your computer with tools based on PC standards, so you can focus on your tasks, not on your connections. Visit www.agilent.com/find/connectivity for more information.

For more information on Agilent Technologies’ products, applications or services, please contact your local Agilent office. The complete list is available at: www.agilent.com/find/contactus

Phone or Fax
United States:
(tel) 800 829 4444
(fax) 800 829 4433
Canada:
(tel) 877 894 4414
(fax) 905 282 6495
China:
(tel) 800 810 0189
(fax) 800 820 2816
Europe:
(tel) 31 20 547 2111
Japan:
(tel) (81) 426 56 7832
(fax) (81) 426 56 7840
Korea:
(tel) (080) 769 0800
(fax) (080) 769 0900
Latin America:
(tel) (305) 269 7500
Taiwan:
(tel) 0800 047 866
(fax) 0800 286 331
Other Asia Pacific Countries:
(tel) (65) 6375 8100
(fax) (65) 6755 0042
Email: tm_ap@agilent.com

Product specifications and descriptions in this document subject to change without notice.

© Agilent Technologies, Inc. 2004
Printed in USA, October 22, 2004
5989-1682EN